Appendix D

ESEM/EDS Data for Test #4, Day-30 Low-Flow Cal-Sil Samples

Figures

Figure D-1.	ESEM image magnified 100 times for a Test #4, Day-30 low-flow exterior	
	raw cal-sil sample. (T4RCEX01.jpg)	D-5
Figure D-2.	ESEM image magnified 500 times for a Test #4, Day-30 low-flow exterior	
	raw cal-sil sample. (t4rcex02.jpg)	D-5
Figure D-3.	EDS counting spectrum for the whole image shown in Figure D-2.	
	(t4rcex03.jpg)	D-6
Figure D-4.	ESEM image magnified 100 times for a Test #4, Day-30 low-flow interior	
	raw cal-sil sample. (t4rcin04.jpg)	D-6
Figure D-5.	ESEM image magnified 500 times for a Test #4, Day-30 low-flow interior	
	raw cal-sil sample. (t4rcin05.jpg)	D-7
Figure D-6.	EDS counting spectrum for the whole image shown in Figure D-5.	
	(t4rcin06.jpg)	D-7
Figure D-7.	ESEM image magnified 100 times for a Test #4, Day-30 low-flow exterior	
	baked cal-sil sample. (T4BCEX07.jpg)	D-8
Figure D-8.	ESEM image magnified 500 times for a Test #4, Day-30 low-flow exterior	
	baked cal-sil sample. (t4bcex08.jpg)	D-8
Figure D-9.	EDS counting spectrum for the whole image shown in Figure D-7.	
	(t4bcex09.jpg)	D-9
Figure D-10.	ESEM image magnified 100 times for a Test #4, Day-30 low-flow interior	
	baked cal-sil sample. (T4BCIN10.jpg)	D-9
Figure D-11.	ESEM image magnified 500 times for a Test #4, Day-30 low-flow interior	
	baked cal-sil sample. (t4bcin11.jpg)	. D-10
Figure D-12.	EDS counting spectrum for the whole image shown in Figure D-11.	
	(t4bcin12.jpg)	. D-10

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This appendix presents the ESEM/EDS results of Test #4, Day-30 raw and baked cal-sil samples submerged in a low-flow zone. The cal-sil samples were collected on the date Test #4 was shut down (June 23, 2005). ESEM was employed to analyze the hydrated cal-sil samples without any coating under a low-vacuum condition (i.e., 80 Pa) to minimize the modification of the cal-sil samples through a drying process. The ESEM/EDS analytical results of the cal-sil samples were obtained on June 30, 2005. EDS results provide a semi-quantitative elemental analysis of the sample compositions.

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Transcribed Laboratory Log

Laboratory session from June 30, 2005.

ESEM/EDS Test #4, Day-30 Low-Flow Cal-Sil



Submerged Raw Cal-Sil (Low-Flow) Exterior

Image:	T4RCEX01	$100 \times$	ESEM image	Figure D-1
	t4rcex02	$500 \times$	ESEM at higher magnification	Figure D-2
EDS:	t4rcex03		EDS on whole image t4rcex02	Figure D-3

Submerged Raw Cal-Sil (Low-Flow) Interior

Image:	t4rcin04	$100 \times$	ESEM image	Figure D-4
	t4rcin05	$500 \times$	ESEM at higher magnification	Figure D-5
EDS:	t4rcin06		EDS of whole image t4rcin05	Figure D-6

Low-Flow Exterior Submerged Baked Cal-Sil

Image:	T4BCEX07	$100 \times$	ESEM image	Figure D-7
	t4bcex08	$500 \times$	ESEM at higher magnification	Figure D-8
EDS:	t4bcex09		EDS of whole image of t4bcex08	Figure D-9

Low-Flow Interior Submerged Baked Cal-Sil

Image:	T4BCIN10	$100 \times$	ESEM image	Figure D-10
	t4bcin11	$500 \times$	ESEM at higher magnification	Figure D-11
EDS:	t4bcin12		EDS of whole image of t4bcin11	Figure D-12



Figure D-1. ESEM image magnified 100 times for a Test #4, Day-30 low-flow exterior raw cal-sil sample. (T4RCEX01.jpg)



Figure D-2. ESEM image magnified 500 times for a Test #4, Day-30 low-flow exterior raw cal-sil sample. (t4rcex02.jpg)



Figure D-3. EDS counting spectrum for the whole image shown in Figure D-2. (t4rcex03.jpg)



Figure D-4. ESEM image magnified 100 times for a Test #4, Day-30 low-flow interior raw cal-sil sample. (t4rcin04.jpg)



Figure D-5. ESEM image magnified 500 times for a Test #4, Day-30 low-flow interior raw cal-sil sample. (t4rcin05.jpg)



Figure D-6. EDS counting spectrum for the whole image shown in Figure D-5. (t4rcin06.jpg)



Figure D-7.ESEM image magnified 100 times for a Test #4, Day-30 low-flow exterior baked cal-
sil sample. (T4BCEX07.jpg)



Figure D-8. ESEM image magnified 500 times for a Test #4, Day-30 low-flow exterior baked calsil sample. (t4bcex08.jpg)



Figure D-9. EDS counting spectrum for the whole image shown in Figure D-7. (t4bcex09.jpg)



Figure D-10. ESEM image magnified 100 times for a Test #4, Day-30 low-flow interior baked calsil sample. (T4BCIN10.jpg)



Figure D-11. ESEM image magnified 500 times for a Test #4, Day-30 low-flow interior baked calsil sample. (t4bcin11.jpg)



Figure D-12. EDS counting spectrum for the whole image shown in Figure D-11. (t4bcin12.jpg)

Appendix E

ESEM and SEM/EDS Data for Test #4, Day-30 Deposition Products

Figures

Figure E-1.	SEM image magnified 500 times for a Test #4, Day-30 fine powder on the submerged rack. (T4D30RackPowder029.bmp)	. E-4
Figure E-2.	SEM image magnified 1000 times for a Test #4, Day-30 fine powder on the submerged rack. (T4D30RackPowder030.bmp)	. E-4
Figure E-3.	EDS counting spectrum for the particles (whole image) shown in Figure E-2. (T4D30RackPowder18.jpg)	. E-5

Tables

Table E-1.Chemical Compositions for T4D30RackPowder18.jpg, Figure E-3E-6

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For ICET, of interest is the corrosion/reaction effect of metal and concrete coupons, as well as the deposition of debris in the tank. To understand the corrosion processes that have occurred in the test, one direct way is the examination of the corrosion/deposition products after the test is completed. For this purpose, the corrosion/deposition products were collected on the date Test #4 was shut down (June 23, 2005). These products are fine powders on the submerged CPVC rack.

These products were collected by directly adhering onto double-sided carbon tapes for probe SEM/EDS examination. After the samples were dried in air, an Au/Pd coating was applied to enhance the surface conductivity of the samples and to prevent possible charging problems during SEM examination. Based on EDS results, a semi-quantitative elemental analysis was performed after calibration. This appendix presents the SEM/EDS data that were obtained on June 29, 2005.

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Transcribed Laboratory Log

Laboratory session from June 29, 2005.

ESEM Test #4, Day-30 Deposition Products

1. Suspended Al	3. Sus. Cu	5. Sus. Gal-Steel	7. Sus. Steel
2. Submerged Al	4. Sub. Cu	6. Sub. Gal Steel	8. Sub. Steel
9. Sediment	10. Powder on	Sub. Rack	



Powder on Submerged Rack

Image:	T4D30RackPowder029	$500 \times$	ESEM image	Figure E-1
	T4D30RackPowder030	$1000 \times$	ESEM at higher magnification	Figure E-2
EDS:	T4D30RackPowder018		EDS of whole of image 30	Figure E-3



Figure E-1. SEM image magnified 500 times for a Test #4, Day-30 fine powder on the submerged rack. (T4D30RackPowder029.bmp)



Figure E-2. SEM image magnified 1000 times for a Test #4, Day-30 fine powder on the submerged rack. (T4D30RackPowder030.bmp)



Figure E-3. EDS counting spectrum for the particles (whole image) shown in Figure E-2. (T4D30RackPowder18.jpg)

The results from the chemical composition analysis for T4D30RackPowder18.jpg are given in Table E-1.

 Table E-1.
 Chemical Compositions for T4D30RackPowder18.jpg, Figure E-3

Jun 29 15:55 2005 /tmp/eds_pout.log Page 1

Group Sample Comment Condition	: NRC : T4D30 : powder : Full Sc Live Ti Acc. Vo Stage F Acq. Da	ID# : 18 on subme ale : 2 me : lt : 1 oint : 1 te : 5	8 erged 20KeV(60.00 15.0 K K=86.2 Wed Ju	rack 10eV/ch 0 sec V 34 Y=55 n 29 15	1,2Kch) Aper Prob 9.512 Z 5:53:49	ture # e Curren =11.000 2005	:2 nt:1	.068E-0	θA
Element	Mode	ROI (Ke	eV)	K-ratio	(%) +	/- Ne	et/Back	ground	
U K	Normal	0.25- 0	1.77	30.973	51 0.0	0014	1027	<i>'</i> ,	3
Na K	Normal	0.81-1	1.27	4.671	.9 0.0	0006	445	',	8
AL K	Normal	1.26- 1	1.78	2.831	15 0.0	0004	390	',	71
SI K	Normal	1.50- 4	2.07	10.606	58 0.0	0007	1361	',	32
Cak	Normal	3.40-4	1.30	15.858	15 0.0	0055	989	<i>'</i> , '	.5
CK	NOTMAL	0.09- 0	1.40	0.151		1001	1	/	10
			Chi	_square	= 1.6	5428			
Element Ma	asst At	omic%	ZAF	z	A	F			
0 5	51.787 66	.6327 1	3652	0.9856	1.3851	1.0000			
Na	8.112 7	.2632 1.	4177	1.0401	1.3635	0.9996			
Al	4.182 3	.1907 1.	2060	1.0015	1.2094	0.9957			
Si 1	5.974 11	.7078 1.	2296	0.9896	1.2431	0.9995			
Ca 1	9.144 9	.8324 0.	9857	0.9980	0.9875	1.0001			
с	0.801 1	.3733 4.	3237	1.0335	4.1836	0.9999			
Total 10 Normalizat	0.000 100	.0000 r = 1.2	247						

Appendix F1

SEM/EDS Data for Test #4, Day-30 Aluminum Coupons

Figures

Figure F1-1.	SEM image magnified 100 times for a Test #4, Day-30 unsubmerged
	aluminum coupon sample. (T4D30AlSusp001.bmp)F1-4
Figure F1-2.	SEM image magnified 500 times for a Test #4, Day-30 unsubmerged
	aluminum coupon sample. (T4D30AlSusp002.bmp)F1-4
Figure F1-3.	Annotated SEM image magnified 1000 times for a Test #4, Day-30
	unsubmerged aluminum coupon sample. (T4D30AlSusp003.bmp)F1-5
Figure F1-4.	EDS counting spectrum for the deposits (EDS1) on the coupon surface shown
	in Figure F1-3. (T4D30AlSusp01.jpg)F1-5
Figure F1-5.	EDS counting spectrum for the flat coupon surface (EDS2) shown in Figure
	F1-3. (T4D30AlSusp02.jpg)
Figure F1-6.	SEM image magnified 100 times for a Test #4, Day-30 submerged aluminum
	coupon sample. (T4D30AlSubm004.bmp)
Figure F1-7.	SEM image magnified 500 times for a Test #4, Day-30 submerged aluminum
	coupon sample. (T4D30AlSubm005.bmp)
Figure F1-8.	Annotated SEM image magnified 1000 times for a Test #4, Day-30
	submerged aluminum coupon sample. (T4D30AlSubm006.bmp)F1-10
Figure F1-9.	EDS counting spectrum for the deposits (EDS3) on the coupon surface shown
	in Figure F1-8. (T4D30AlSubm03.jpg)
Figure F1-10.	EDS counting spectrum for the flat coupon surface (EDS4) shown in Figure
	F1-8. (T4D30AlSubm04.jpg)
Figure F1-11.	SEM image magnified 5000 times for a Test #4, Day-30 submerged
	aluminum coupon sample. (T4D30AlSubm007.bmp)F1-14

Tables

Table F1-1.	Chemical Compositions for T4D30AlSusp01.jpg, Figure F1-4	F1-6
Table F1-2.	Chemical Compositions for T4D30AlSusp02.jpg, Figure F1-5	F1-8
Table F1-3.	Chemical Compositions for T4D30AlSubm03.jpg, Figure F1-9	F1-11
Table F1-4.	Chemical Compositions for T4D30Alsubm04.jpg, Figure F1-10	F1-13

This appendix shows the SEM/EDS results for the metal aluminum coupons under two categories: (1) unsubmerged and (2) submerged. Unsubmerged refers to coupons held in the test tank gas space above the water level of the solution during ICET. Unsubmerged coupons were contacted by the solution only during the 4-hour spraying period at the initial date of the test. In addition, the surface of the unsubmerged coupons may also have been affected by the moisture in the gas space during the test. Submerged refers to the coupons that were under the solution during the test.

The coupon samples were collected on June 23, 2005 (the date Test #4 was shut down) and examined by SEM/EDS on June 29, 2005. The aluminum coupon samples were dried in air before being coated with Au/Pd for SEM examination. SEM results present the surface condition of the aluminum coupons. In addition, EDS results provide a semi-quantitative elemental analysis of the coupon surface and the corrosion products.

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Transcribed Laboratory Log

Laboratory session from June 29, 2005. SEM Test #4, Day-30 Aluminum Coupons

1. Unsubmerged Al	3. Sus. Cu	5. Sus. Gal-Steel	7. Sus. Steel
2. Submerged Al	4. Sub. Cu	6. Sub. Gal Steel	8. Sub. Steel
9. Sediment	10. Powder on	Sub. Rack	



Unsubmerged Aluminum Coupons

Image:	T4D30A1Susp001	$100 \times$	SEM image	Figure F1-1
	T4D30AlSusp002	$500 \times$	SEM image higher magnification	Figure F1-2
	T4D30AlSusp003 1000		SEM annotated image	Figure F1-3
EDS:	EDS: T4D30AlSusp01		On particles at Al surface shown in image T4D30AlSusp003	Figure F1-4
	T4D30A1Susp02		On Al coupon surface shown in image T4D30AlSusp003	Figure F1-5

Submerged Al Coupon

Image:	T4D30AlSubm004	$100 \times$	SEM image of fiberglass	Figure F1-6
	T4D30AlSubm005	$500 \times$	SEM image higher magnification	Figure F1-7
	T4D30AlSubm006	$1000 \times$	SEM annotated image	Figure F1-8
EDS:	T4D30AlSubm03		EDS of particles shown in 006	Figure F1-9
	T4D30Alsubm04		EDS of Al surface in 006	Figure F1-10
Image:	T4D30AlSubm007	$5000 \times$	SEM image higher magnification	Figure F1-11



Figure F1-1. SEM image magnified 100 times for a Test #4, Day-30 unsubmerged aluminum coupon sample. (T4D30AlSusp001.bmp)



Figure F1-2. SEM image magnified 500 times for a Test #4, Day-30 unsubmerged aluminum coupon sample. (T4D30AlSusp002.bmp)



Figure F1-3. Annotated SEM image magnified 1000 times for a Test #4, Day-30 unsubmerged aluminum coupon sample. (T4D30AlSusp003.bmp)



Figure F1-4. EDS counting spectrum for the deposits (EDS1) on the coupon surface shown in Figure F1-3. (T4D30AlSusp01.jpg)

The results from the chemical composition analysis for T4D30AlSusp01.jpg are given in Table F1-1.

Table F1-1. Chemical Compositions for T4D30AlSusp01.jpg, Figure F1-4

Jun 29 10:11 2005

Group Sample Comment Condition	: NRC : T4D30 : Parti : Full Live Acc. Stage Acq.	D ID# : Scale Time Volt Point Date	1 suspend : 20KeV : 60.0 : 15.0 : X=86. : Wed J	ed Al (10eV/c) 00 sec KV 836 Y=5 un 29 1	h,2Kch) Aper Prob 3.400 Z 0:06:34	ture # e Curr =10.78 2005	: 2 ent : 1 6	.069E-09 A
Flement	Mode	DOT	(Voll)	W. matil	(0)	, .		
DIEmenic	Normal	ROI	(Kev)	K-ratio	D(8) +	/-	Net/Bac	kground
No K	Normal	0.25	- 0.77	49.77	L3 0.	0017	1653	/ 8
NAK	Normal	0.81	- 1.27	6.57	4 0.	0007	627	/ 6
	Normal	1.26	- 1.78	29.78.	35 0.	0010	4103	/ 29
SI K	Normal	. 1.50	- 2.07	3.110	03 0.	0004	400	/ 238
Cak	Normal	3.40	- 4.30	1.85	30 0.	0027	116	/ 2
CK	Normal	0.09	- 0.46	0.11	37 0.	0001	6	/ 16
			Ch	i_square	= 3.	1919		
Element Ma	888	Atomic*	ZAF	Z	Α	F		
0 4	7.921	60.0922	0.9108	0.9888	0.9212	0.999	9	
Na	8.495	7.4130	1.2222	1.0435	1,1736	0.998	0	
Al 3	5.757	26.5870	1.1356	1.0048	1,1313	0.999	n n	
Si	5.079	3.6282	1.5447	0.9930	1.5557	1 000	0	
Ca	1.975	0.9887	1.0056	1.0019	1 0036	1 000	1	
C ·	0.773	1.2909	6.4296	1.0368	6.2020	1.0000	, D	
Total 10	0.000 1	00.0000						
Normalizat								



Figure F1-5. EDS counting spectrum for the flat coupon surface (EDS2) shown in Figure F1-3. (T4D30AlSusp02.jpg)

The results from the chemical composition analysis for T4D30AlSusp02.jpg are given in Table F1-2.

Table F1-2. Chemical Compositions for T4D30AlSusp02.jpg, Figure F1-5

. . Jun 29 10:15 2005 Group : NRC Sample : T4D30 ID# : 2 Comment : Surface of suspended Al Condition : Full Scale : 20KeV(10eV/ch,2Kch) Live Time : 60.000 sec Aperture # : 2 Acc. Volt : 15.0 KV Probe Current : 1. Probe Current : 1.068E-09 A Stage Point : X=86.836 Y=58.400 Z=10.786 Acq. Date : Wed Jun 29 10:13:59 2005 Element Mode ROI (KeV) K-ratio(%) +/-Net/Background ОК Normal 0.25- 0.77 36.6938 0.0015 1217 / 4 Na K Normal 0.81- 1.27 1.3775 0.0004 131 / 8 57.7086 Al K Normal 1.26- 1.78 0.0014 7943 / 24 Si K Normal 1.50- 2.07 1.7543 0.0003 225 / 430 ------------Chi square = 4.6847ZAF Element Mass% Atomic* \mathbf{z} А F 36.111 48.7449 0.9776 0.9856 0.9919 0.9999 0 Na 1.540 1.4468 1.1106 1.0400 1.0727 0.9956 Al 59.291 47.4571 1.0206 1.0013 1.0198 0.9995 Si 3.058 2.3512 1.7314 0.9893 1.7500 1.0000 _____ ----------Total 100.000 100.0000 Normalization factor = 1.0067



Figure F1-6. SEM image magnified 100 times for a Test #4, Day-30 submerged aluminum coupon sample. (T4D30AlSubm004.bmp)



Figure F1-7. SEM image magnified 500 times for a Test #4, Day-30 submerged aluminum coupon sample. (T4D30AlSubm005.bmp)



Figure F1-8. Annotated SEM image magnified 1000 times for a Test #4, Day-30 submerged aluminum coupon sample. (T4D30AlSubm006.bmp)



Figure F1-9. EDS counting spectrum for the deposits (EDS3) on the coupon surface shown in Figure F1-8. (T4D30AlSubm03.jpg)

The results from the chemical composition analysis for T4D30AlSubm03.jpg are given in Table F1-3.

Table F1-3. Chemical Compositions for T4D30AlSubm03.jpg, Figure F1-9

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Group Sample Comment Condition	: NRC : T4D3 : Part : Full Live Acc. Stag Acq.	0 ID# : icles on Scale Time Volt Volt Date	3 submer : 20KeV : 60.0 : 15.0 : X=74. : Wed J	ged Al (10eV/c) 00 sec KV 706 Y=6; un 29 10	h,2Kch) Aper Prob 2.388 Z 0:30:29	ture # e Curre =10.786 2005	: 2 nt : 1.	.067E-09	A
Element	Mode	ROI	(KeV)	K-ratio	o(%t) +	/- N	et/Back	ground	
CK	Norma	1 0.09	- 0.46	0.59	99 0.	0002	29	7	15
ок	Norma	1 0.25	- 0.77	68.443	38 0.	0020	2268		16
Na K	Norma	1 0.81	- 1.27	9.15	59 0.	0008	872	1	18
Mg K	Norma	1 0.97	- 1.57	1.20	76 0.	0002	167	1	24
AĨ K	Norma	1 1.26	- 1.78	9.95	77 0.	0007	1369	1 3	79
Si K	Norma	1 1.50-	- 2.07	8.14	30 0	0007	1045	<i>'</i> ,	é.
CaK	Norma	1 3.40-	4.30	13.30	30 0.	0052	829	',	4
			Ch	i_square	e = 3.4	4940			
Element Ma	188%	Atomic*	ZAF	z	A	F			
с	2.021	3.2391	4.2355	1.0372	4.0840	0.9999			
0 5	57.541	69.2225	1.0567	0.9892	1.0682	1.0000			
Na 1	LO.097	8.4534	1.3860	1.0441	1.3282	0.9994			
Ma	1.535	1,2155	1.5981	0.9830	1.6294	0.9978			
AI	9.810	6.9977	1.2382	1.0055	1.2340	0.9980			
Si	8.534	5.8480	1.3164	0.9937	1.3251	0.9998			
Ca 1	10.462	5.0238	0.9881	1.0029	0.9851	1.0001			
Total 10 Normalizat	00.000 ion fa	100.0000 ctor = (.7956						-



Figure F1-10. EDS counting spectrum for the flat coupon surface (EDS4) shown in Figure F1-8. (T4D30AlSubm04.jpg)

The results from the chemical composition analysis for T4D30Alsubm04.jpg are given in Table F1-4.

Table F1-4. Chemical Compositions for T4D30Alsubm04.jpg, Figure F1-10

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Group : Sample : Comment : Condition :	NRC T4D30 ID Surface o Full Scal Live Time Acc. Volt Stage Poi Acq. Date	# : 4 f submerged e : 20KeV(: 60.00 : 15.0 K nt : X=74.6 : Wed Jus	Al 10eV/ch,2Kd 0 sec Ar V Pr 53 Y=62.211 n 29 10:41:	ch) perture # cobe Curren L Z=10.786 51 2005	: 2 nt : 1.068E-09 A	
Element	Mode	ROT (KeV)	K-ratio(%)	+/- N4	t /Background	
OK	Normal 0	.25- 0.77	23.8625	0.0013	792 / 7	
Na K	Normal 0	.81- 1.27	1.5073	0.0005	144 / 13	
Al K	Normal 1	.26- 1.78	98.1067	0.0019	13504 / 30	
Si K	Normal 1	.50- 2.07	2.4247	0.0004	311 / 724	
		Chi	square =	2.7984		
Element Mas	s% Atom	ic% ZAF	z	A F		
0 20	.718 30.5	721 1.1041	0.9815 1.12	250 0.9999		
Na 1	.176 1.2	077 0.9922 :	1.0354 0.96	48 0.9933		
Al 74	.561 65.2	404 0.9665 (0.9967 0.97	702 0.9995		
Si 3	.545 2.9	798 1.8592 (0.9847 1.88	881 1.0000		
Total 100 Normalizati	.000 100.0 on factor	000 - 0.7863				



Figure F1-11. SEM image magnified 5000 times for a Test #4, Day-30 submerged aluminum coupon sample. (T4D30AlSubm007.bmp)